



DUAL N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	RDS(ON) Max	I _D Tc = +25°C	
30V	20mΩ @ V _{GS} = 10V	16A	
30 V	$32mΩ @ V_{GS} = 4.5V$	13A	

Description

This new generation MOSFET has been designed to minimize the on-state resistance (RDS(ON)) yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Backlighting
- Power Management Functions
- DC-DC Converters

SO-8 S1 1 0 8 D1 G1 2 7 D1 S2 3 6 D2 G2 4 5 D2

Top View Internal Schematic

Features

- Dual N-Channel MOSFET
- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- 100% Unclamped Inductive Switching (UIS) Test in Production

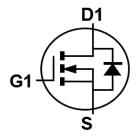
 Ensures More Reliable and Robust End Application
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please <u>contact us</u> or your local Diodes representative.

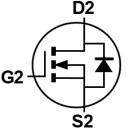
https://www.diodes.com/quality/product-definitions/

 An Automotive-Compliant Part is Available Under Separate Datasheet (DMT3020LSDQ)

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Lead Frame. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.072 grams (Approximate)





N-Channel MOSFET

N-Channel MOSFET

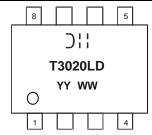
Ordering Information (Note 4)

Part Number	Case	Packaging
DMT3020LSD-13	SO-8	2500/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



);; = Manufacturer's Marking
T3020LD = Product Type Marking Code
YYWW = Date Code Marking
YY or YY= Year (ex: 21 = 2021)
WW = Week (01 to 53)



Maximum Ratings (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	30	V
Gate-Source Voltage	Vgss	±20	V
Continuous Drain Current, V _{GS} = 10V (Note 7)	ID	16 13	А
Maximum Body Diode Forward Current (Note 7)	Is	8	Α
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%	I _{DM}	50	A
Pulsed Drain Body Diode Forward Current (10µs Pu	lsм	50	A
Avalanche Current (L = 0.1mH) (Note 8)	I _{AS}	13	A
Avalanche Energy (L = 0.1mH) (Note 8)	Eas	8.5	mJ

Thermal Characteristics ($@T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit	
Total Power Dissipation (Note 5)		P_{D}	1.0	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	$R_{\theta JA}$	117	°C/W
Total Power Dissipation (Note 6)		Pp	1.5	W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	81	°C/W	
Thermal Resistance, Junction to Case (Note 7)	R _θ JC	20	C/VV	
Operating and Storage Temperature Range		TJ, TSTG	-55 to +150	°C

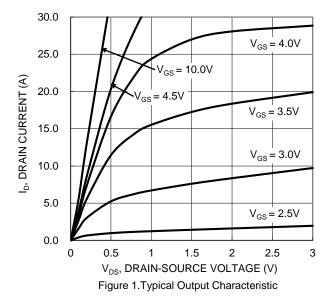
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)						
Drain-Source Breakdown Voltage	BVDSS	30.0	_	_	V	$V_{GS} = 0V, I_{D} = 250\mu A$
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}	_	_	1.0	μΑ	$V_{DS} = 24V$, $V_{GS} = 0V$
Gate-Source Leakage	Igss	_	_	±100	nA	$V_{GS} = \pm 20V$, $V_{DS} = 0V$
ON CHARACTERISTICS (Note 9)						
Gate Threshold Voltage	Vgs(TH)	1.0	_	2.5	٧	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
Static Drain-Source On-Resistance	P- avair		_	20	mΩ	V _{GS} = 10V, I _D = 9.0A
Static Dialit-Source Off-Resistance	R _{DS(ON)}		_	32	11152	$V_{GS} = 4.5V, I_{D} = 7.0A$
Diode Forward Voltage	VsD	_	_	1.2	V	V _G S = 0V, I _S = 2A
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	Ciss	_	393	_	pF	15)/)/ 0)/
Output Capacitance	Coss	_	173	_	рF	$V_{DS} = 15V, V_{GS} = 0V,$ - f = 1.0MHz
Reverse Transfer Capacitance	Crss	_	27	_	pF	1 = 1.000112
Gate Resistance	Rg	_	1.1	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1.0MHz$
Total Gate Charge (V _{GS} = 10V)	Qg	_	7.0	_	nC	
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	3.6	_	nC	V _{DD} = 15V. I _D = 9A
Gate-Source Charge	Q _{gs}	_	0.9	_	nC	VDD = 15V, ID = 9A
Gate-Drain Charge	Qgd	_	1.5	_	nC	
Turn-On Delay Time	tD(ON)	_	1.8	_	ns	
Turn-On Rise Time	t _R	_	1.9	_	ns	$V_{DD} = 15V, V_{GS} = 10V,$
Turn-Off Delay Time	tD(OFF)	_	7.5	_	ns	$R_G = 6\Omega$, $I_D = 9A$
Turn-Off Fall Time	tF	_	2.4	_	ns	
Reverse Recovery Time	trr	_	10	_	ns	L 00 d1/dt 4000///-
Reverse Recovery Charge	Qrr	_	2.6	_	nC	I _F = 9A, dl/dt = 100A/μs

Notes

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 7. Thermal resistance from junction to soldering point (on the exposed drain pad).
- 8. IAS and EAS ratings are based on low frequency and duty cycles to keep $T_J = +25$ °C.
- 9. Short duration pulse test used to minimize self-heating effect.
- 10. Guaranteed by design. Not subject to product testing.





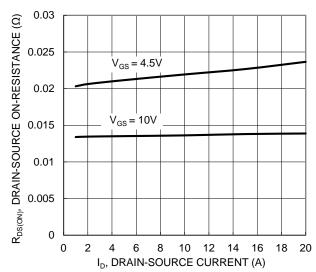


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

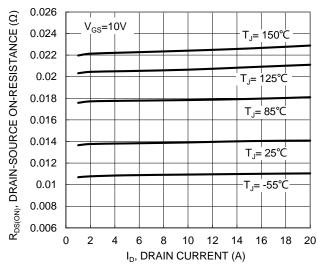
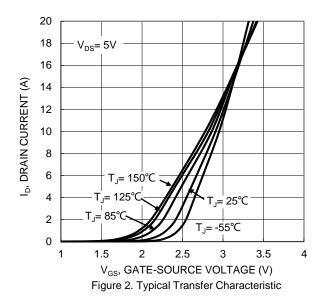


Figure 5. Typical On-Resistance vs. Drain Current and Temperature



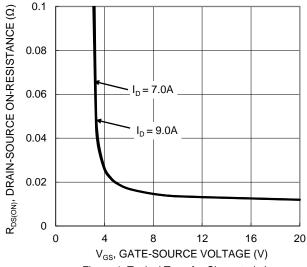


Figure 4. Typical Transfer Characteristic

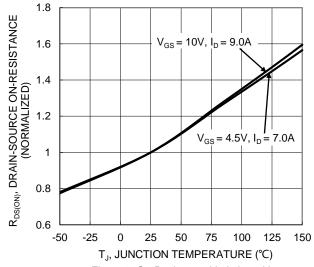


Figure 6. On-Resistance Variation with Temperature



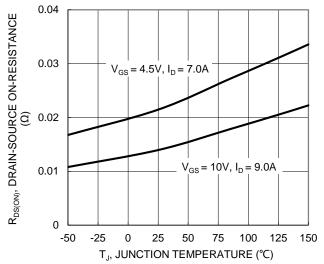


Figure 7. On-Resistance Variation with Temperature

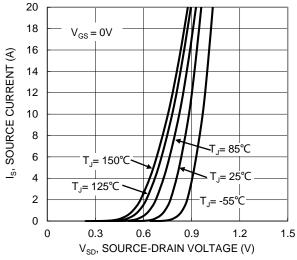


Figure 9. Diode Forward Voltage vs. Current

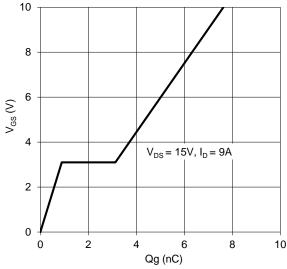


Figure 11. Gate Charge

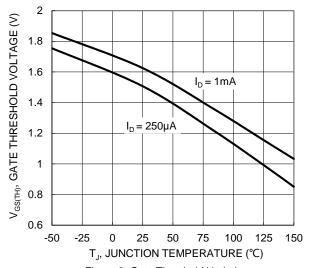


Figure 8. Gate Threshold Variation vs. JunctionTemperature

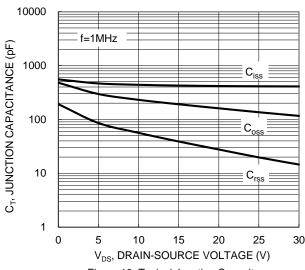


Figure 10. Typical Junction Capacitance

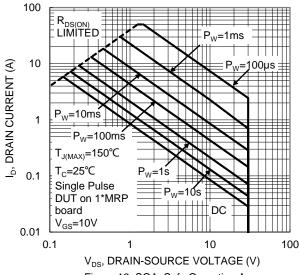


Figure 12. SOA, Safe Operation Area



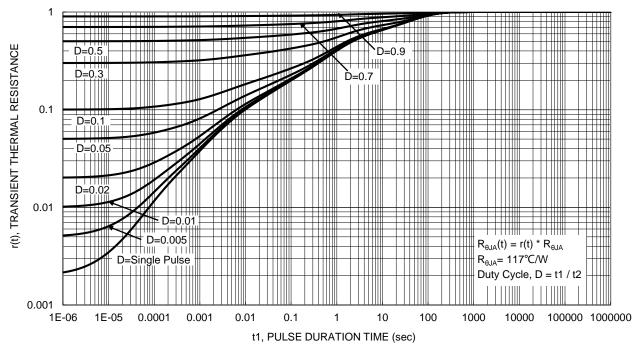
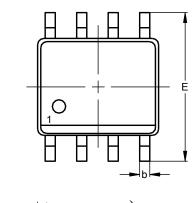


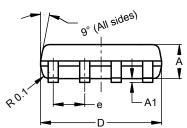
Figure 13. Transient Thermal Resistance

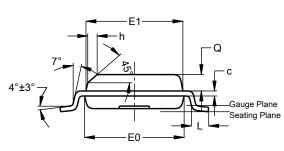


Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.







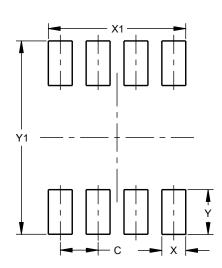
SO-8

SO-8						
Dim	Min	Max	Тур			
Α	1.40	1.50	1.45			
A 1	0.10	0.20	0.15			
p	0.30	0.50	0.40			
C	0.15	0.25	0.20			
D	4.85	4.95	4.90			
Е	5.90	6.10	6.00			
E1	3.80	3.90	3.85			
E0	3.85	3.95	3.90			
е	1		1.27			
h	-		0.35			
L	0.62	0.82	0.72			
Ø	0.60	0.70	0.65			
All Dimensions in mm						

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.





Dimensions	Value (in mm)				
С	1.27				
Х	0.802				
X1	4.612				
Υ	1.505				
Y1	6.50				



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